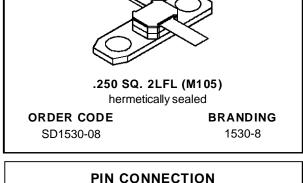


SD1530-08

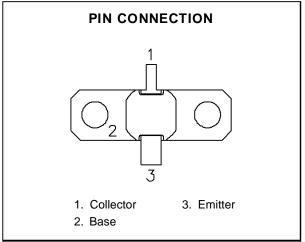
RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- DESIGNED FOR HIGH POWER PULSED IFF, DME, TACAN APPLICATIONS
- 40 WATTS (typ.) IFF 1030 1090 MHz
- 35 WATTS (min.) DME 1025 1150 MHz
- 25 WATTS (typ.) TACAN 960 1215 MHz
- 9.0 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- EMITTER BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- INFINITE LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION



DESCRIPTION

The SD1530-08 is a gold metallized silicon, NPN power transistor designed for applications requiring high peak power and low duty cycles such as IFF, DME and TACAN. The SD1530-08 is packaged in the .250" input matched hermetic stripline flange package resulting in improved broadband performance and a low thermal resistance.



ABSOLUTE MAXIMUM RATINGS $(T_{case} = 25^{\circ}C)$

Symbol	Parameter	Value	Unit	
V _{CBO}	Collector-Base Voltage	65	V	
V _{CEO}	Collector-Emitter Voltage	65	V	
V _{EBO}	Emitter-Base Voltage	3.5	V	
Ic	Device Current	2.6	А	
Poiss	Power Dissipation	87.5	W	
TJ	Junction Temperature	+200	°C	
T _{STG}	Storage Temperature	- 65 to +150	°C	

THERMAL DATA

R _{TH(j-c)} Junction-Case Thermal Resistance	2.0	°C/W
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ELECTRICAL SPECIFICATIONS (Tcase = 25°C)

STATIC

Symbol	Test Conditions	Value			Unit		
		Min.	Тур.	Max.			
ВУсво	I _C = 10 mA	$I_E = 0 \text{ mA}$		65	_	_	V
BVces	I _C = 25 mA	V _{BE} = 0 V		65	_	_	V
BV _{EBO}	I _E = 1 mA	$I_C = 0 \text{ mA}$		3.5	_		V
I _{CES}	V _{CE} = 50 V	$I_E = 0 \text{ mA}$		_		5	mA
h _{FE}	V _{CE} = 5 V	$I_C = 500 \text{ mA}$		10	_	200	

DYNAMIC

Symbol	Test Conditions		Value		Unit
Symbol	rest conditions	Min. Typ. Max.			
Pout	$f = 1025 - 1150 \text{ MHz}$ $P_{IN} = 5.0 \text{ W}$ $V_{CE} = 50 \text{ V}$	35	_	_	W
Pg	f = 1025 - 1150 MHz PIN = 5.0 W VCE = 50 V	8.5	_	_	dB
ης	f = 1025 - 1150 MHz P _{IN} = 5.0 W V _{CE} = 50 V	30	_	_	%

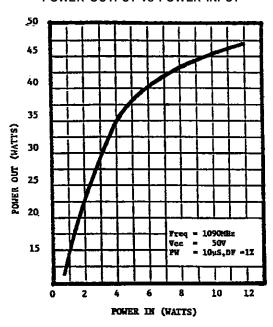
Note: Pulse Width = 10μ Sec, Duty Cycle = 1%

This device is suitable for use under other pulse width/duty cycle conditions.

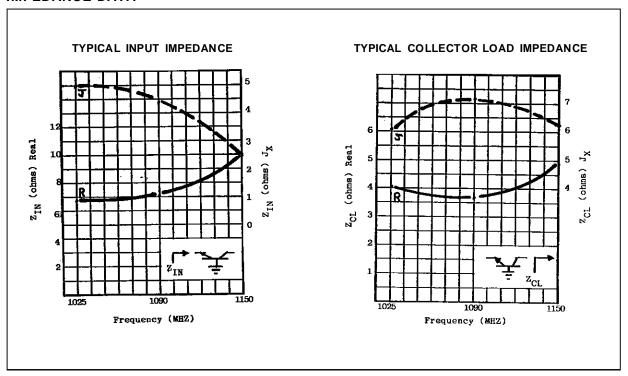
Please contact the factory for specific applications assistance.

TYPICAL PERFORMANCE

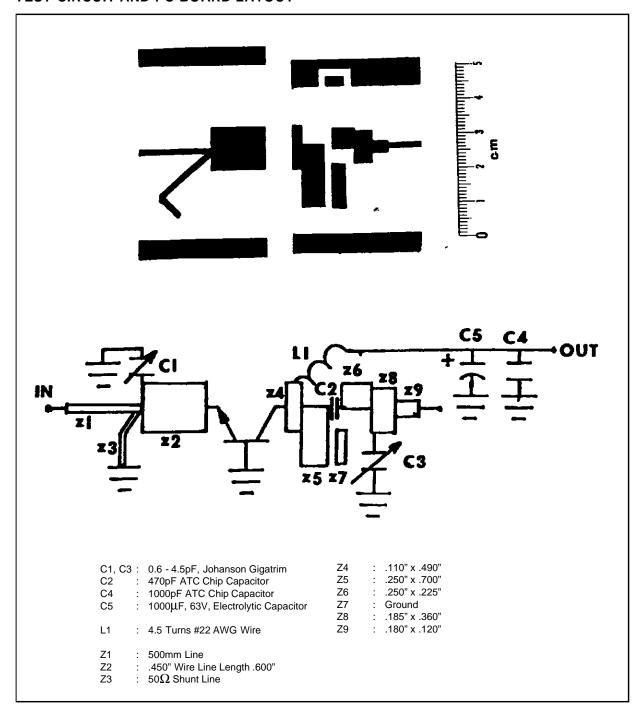
POWER OUTPUT vs POWER INPUT



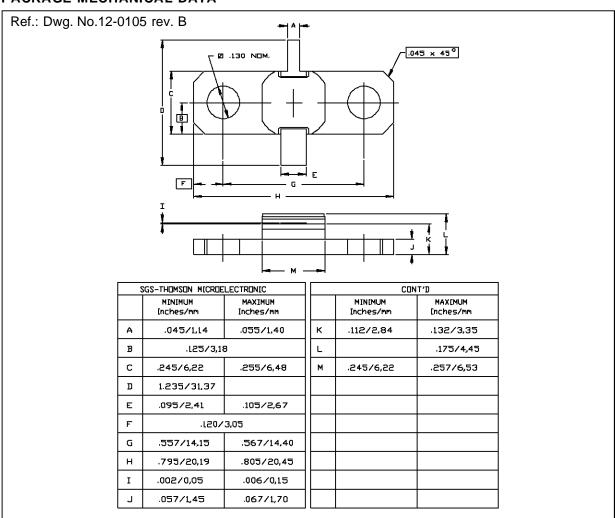
IMPEDANCE DATA



TEST CIRCUIT AND PC BOARD LAYOUT



PACKAGE MECHANICAL DATA



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